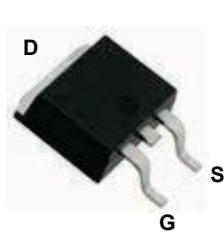
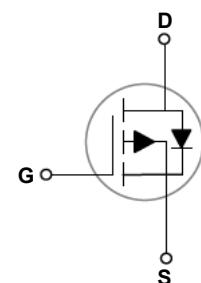


Main Product Characteristics

$V_{(BR)DSS}$	-100V
$R_{DS(ON)}$	210mΩ
I_D	-10A



TO-252 (DPAK)



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The GSFD1011 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Ratings ($T_c=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	V_{DS}	-100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous ($T_c=25^\circ\text{C}$)	I_D	-10	A
Drain Current-Continuous ($T_c=100^\circ\text{C}$)		-6.5	
Drain Current-Pulsed ¹	I_{DM}	-40	A
Power Dissipation ($T_c=25^\circ\text{C}$)	P_D	54	W
Power Dissipation-Derate above 25°C		0.43	W/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62	°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.3	°C/W
Operating Junction Temperature Range	T_J	-55 To +150	°C
Storage Temperature Range	T_{STG}	-55 To +150	°C

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
On/Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-100	-	-	V
BV_{DSS} Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_{\text{D}}=-1\text{mA}$	-	-	-	$\text{V}/^\circ\text{C}$
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=-100\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	-1	μA
		$V_{\text{DS}}=-80\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	-10	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Static Drain-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-5\text{A}$	-	170	210	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-2\text{A}$	-	190	230	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=-250\mu\text{A}$	-1	-	-3	V
Forward Transconductance	g_{fs}	$V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-3\text{A}$	-	7	-	S
Dynamic and Switching Characteristics						
Total Gate Charge	Q_g	$V_{\text{DS}}=-80\text{V}, I_{\text{D}}=-5\text{A}$ $V_{\text{GS}}=-10\text{V}$	-	20	40	nC
Gate-Source Charge	Q_{gs}		-	3.5	7	
Gate-Drain Charge	Q_{gd}		-	4.6	9	
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=-50\text{V}, R_{\text{G}}=25\Omega$ $V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-5\text{A}$	-	18	36	nS
Rise Time	t_r		-	8	16	
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	100	200	
Fall Time	t_f		-	30	60	
Input Capacitance	C_{iss}	$V_{\text{DS}}=-25\text{V}, V_{\text{GS}}=0\text{V}, F=1\text{MHz}$	-	1419	2500	pF
Output Capacitance	C_{oss}		-	89	170	
Reverse Transfer Capacitance	C_{rss}		-	45	90	
Gate Resistance	R_g	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$	-	16	-	Ω
Drain-Source Diode Characteristics and Maximum Ratings						
Continuous Source Current	I_s	$V_G=V_D=0\text{V},$ Force Current	-	-	-10	A
Pulsed Source Current	I_{SM}		-	-	-20	A
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_s=-1\text{A}, T_J=25^\circ\text{C}$	-	-	-1.2	V
Reverse Recovery Time ²	t_{rr}	$V_{\text{GS}}=0\text{V}, I_s=-5\text{A}$ $dI/dt=100\text{A}/\mu\text{s}$ $T_J=25^\circ\text{C}$	-	26.6	-	nS
Reverse Recovery Charge ²	Q_{rr}		-	24.2	-	nC

Note:

- Repetitive Rating: Pulsed width limited by maximum junction temperature.
- Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

Typical Electrical and Thermal Characteristic Curves

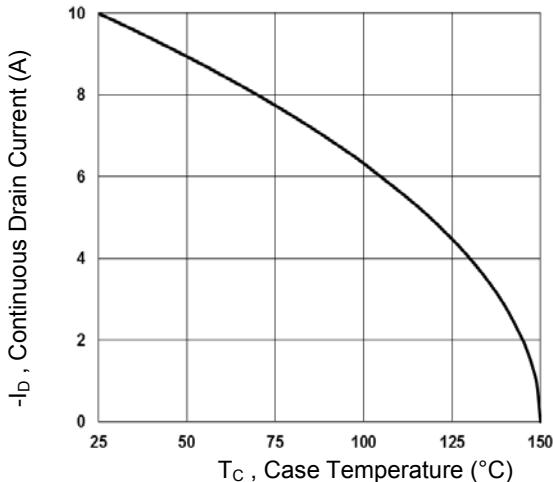


Figure 1. Continuous Drain Current vs. T_c

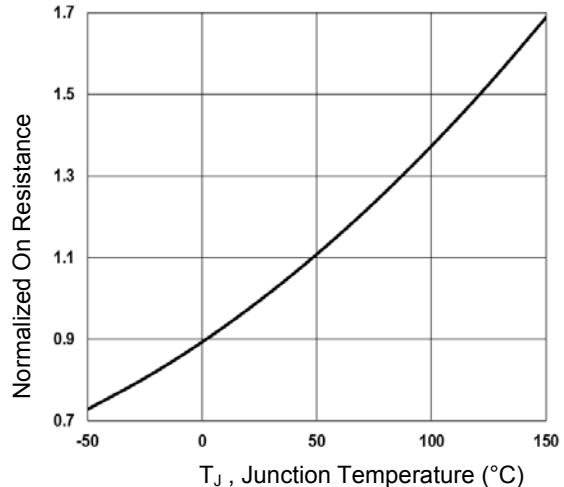


Figure 2. Normalized R_{DS(ON)} vs. T_j

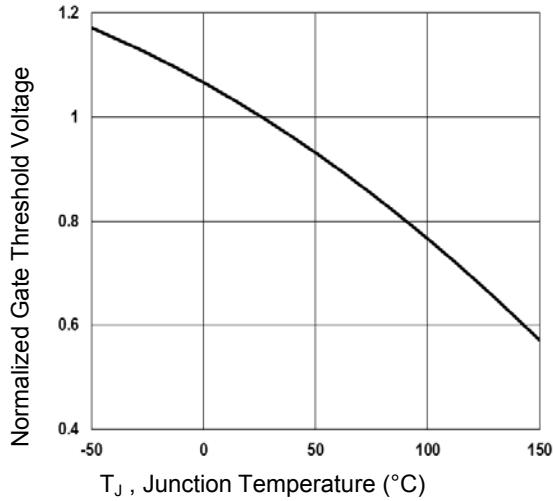


Figure 3. Normalized V_{th} vs. T_j

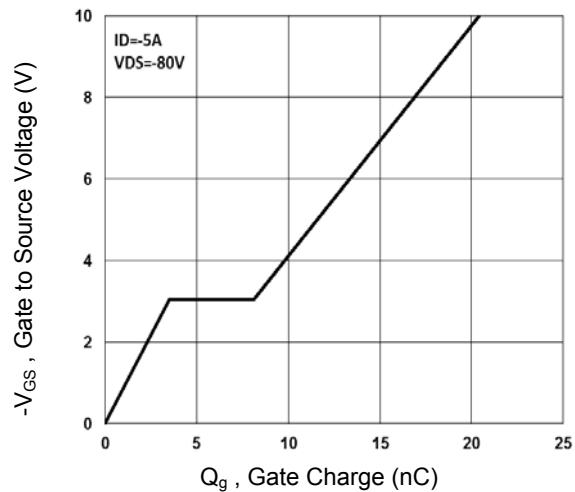


Figure 4. Gate Charge Waveform

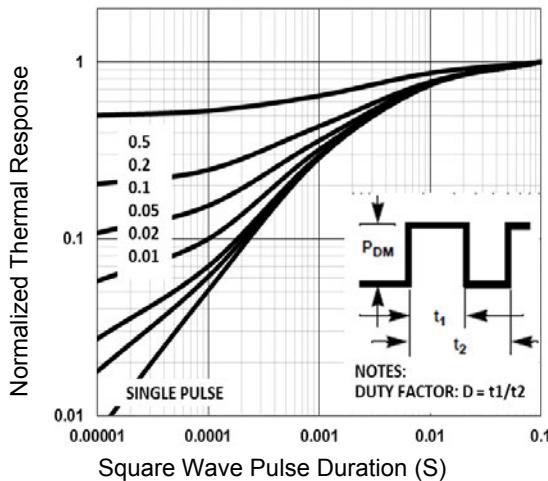


Figure 5. Normalized Transient Impedance

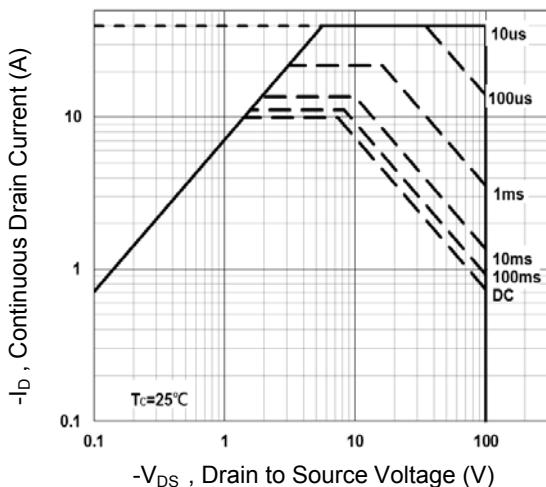


Figure 6. Maximum Safe Operation Area

Typical Electrical and Thermal Characteristic Curves

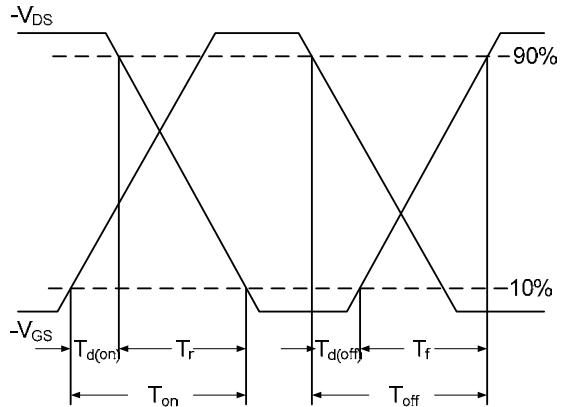


Figure 7. Switching Time Waveform

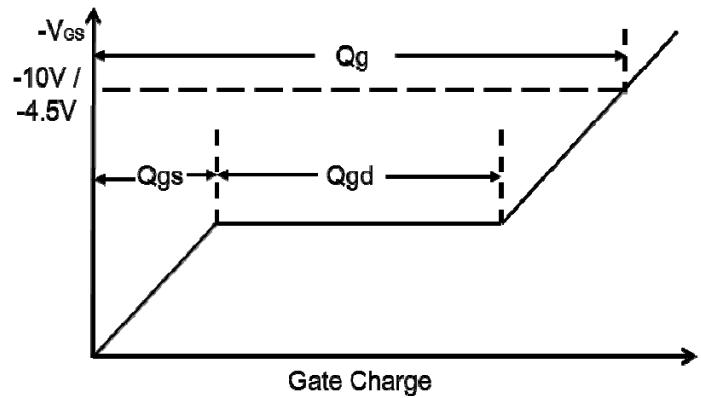
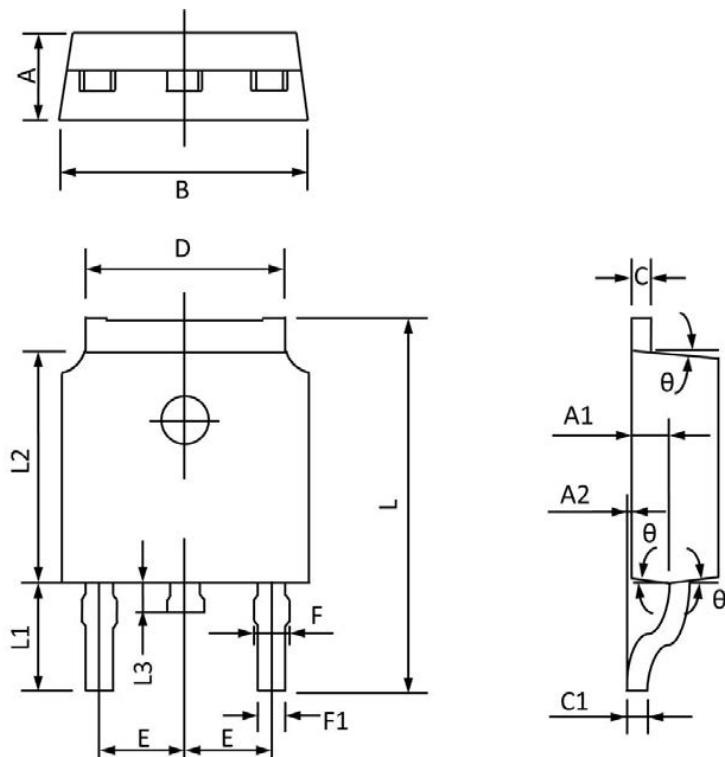


Figure 8. Gate Charge Waveform

Package Outline Dimensions

TO-252 (DPAK)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	2.200	2.400	0.087	0.094
A1	0.910	1.110	0.036	0.044
A2	0.000	0.150	0.000	0.006
B	6.500	6.700	0.256	0.264
C	0.460	0.580	0.018	0.230
C1	0.460	0.580	0.018	0.030
D	5.100	5.460	0.201	0.215
E	2.186	2.386	0.086	0.094
F	0.740	0.940	0.029	0.037
F1	0.660	0.860	0.026	0.034
L	9.800	10.400	0.386	0.409
L1	2.9REF		0.114REF	
L2	6.000	6.200	0.236	0.244
L3	0.600	1.000	0.024	0.039
θ	3°	9°	3°	9°